

# EE6361 : Importance Sampling

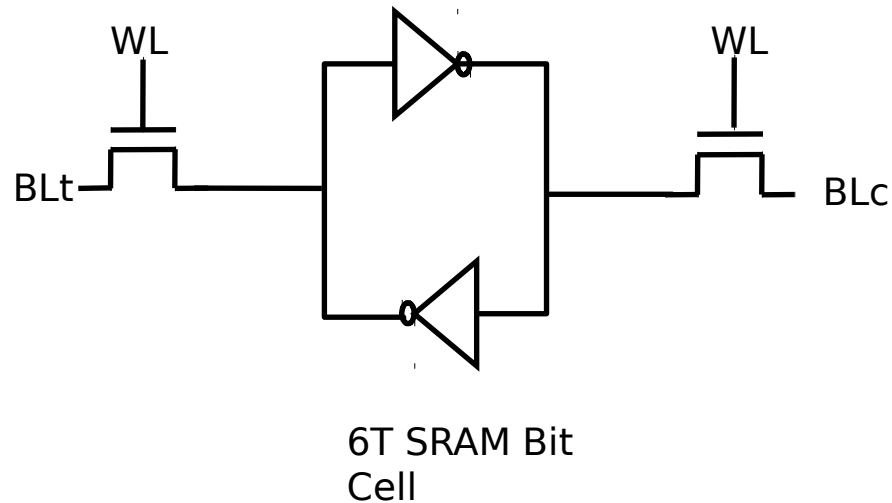
Electrical Engineering Department  
IIT Madras

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## Agenda

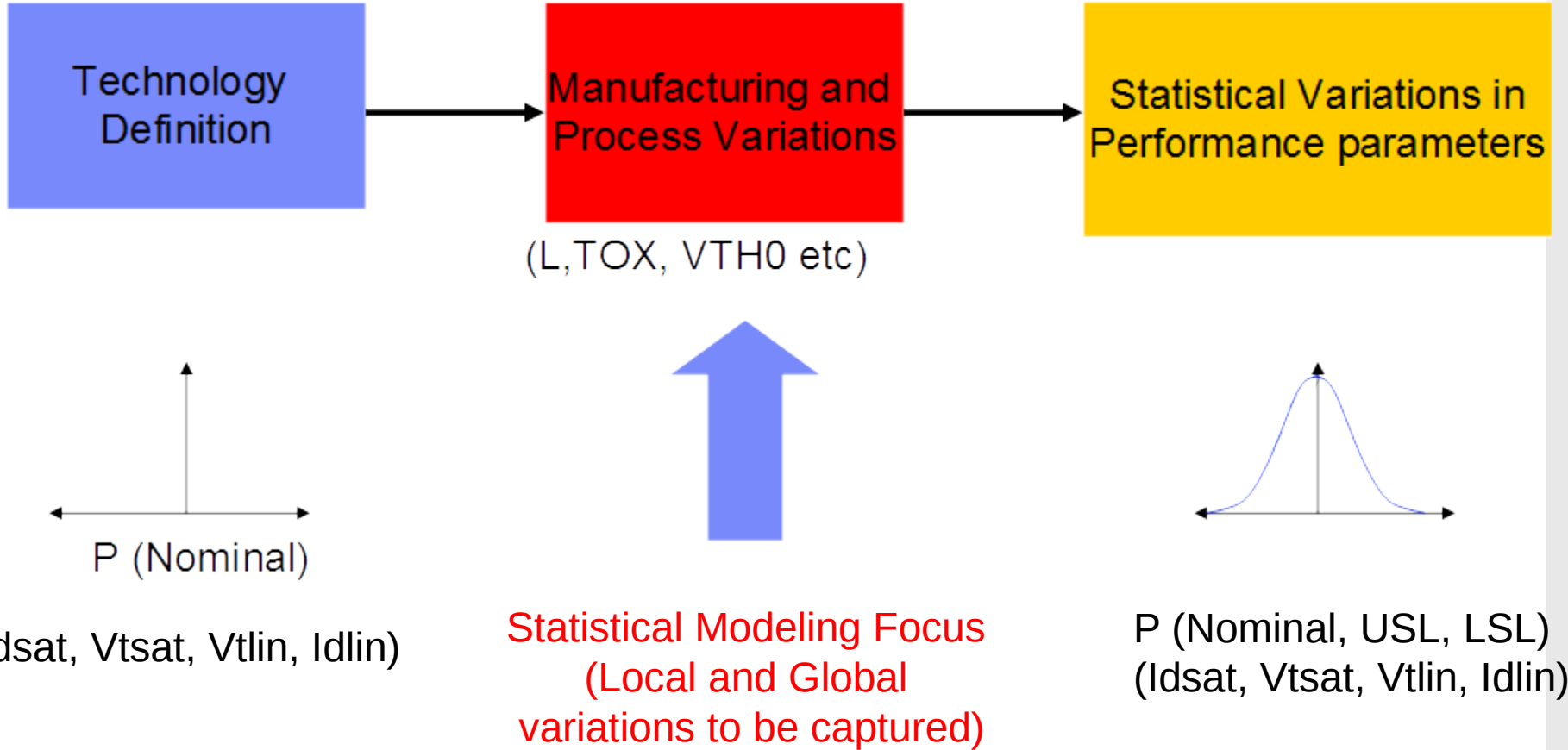
- Yield analysis in memories
- Statistical Compact Model
- Traditional Monte-Carlo
- Limitations of Monte-Carlo
- Variance Reduction
- Importance Sampling
- Statistical Blockade

## Yield Analysis in Memories



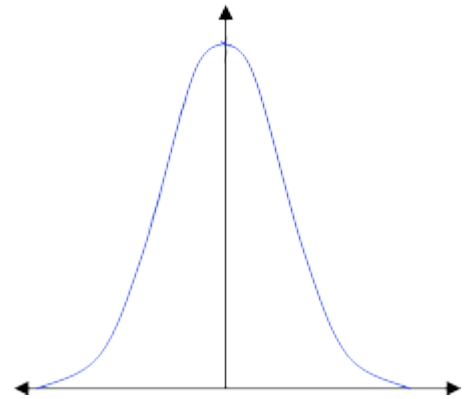
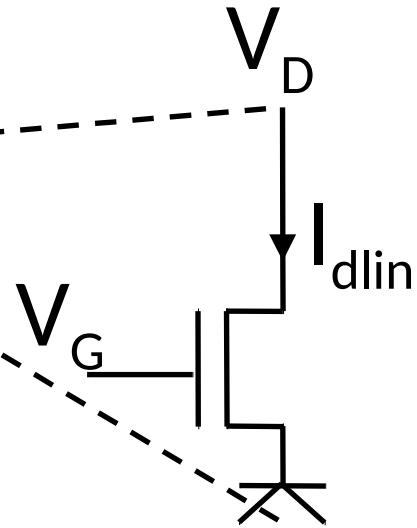
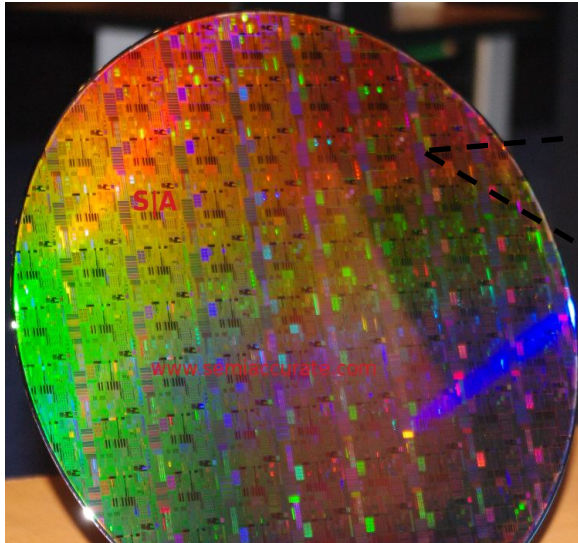
- Smallest possible transistors used
  - Prone to large variability
- Very high yield expected (99.9999%)
  - Foundry has to guarantee

## Variability in Fab



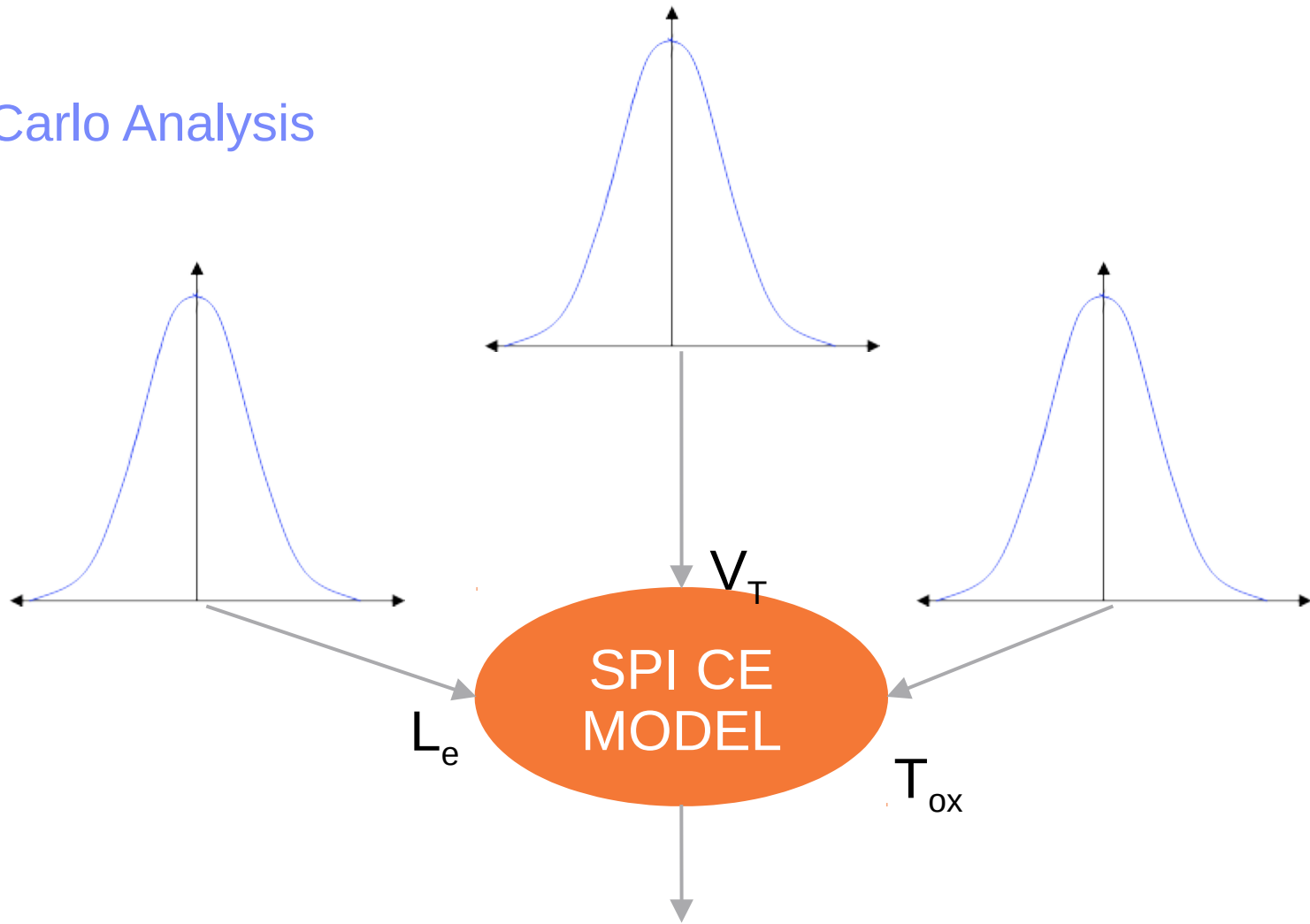
- Statistical compact model available to designers for use

# Statistical Compact Model



- Maps measured variations of voltages and currents to process variations
  - Back propagation of Variance

## Monte Carlo Analysis

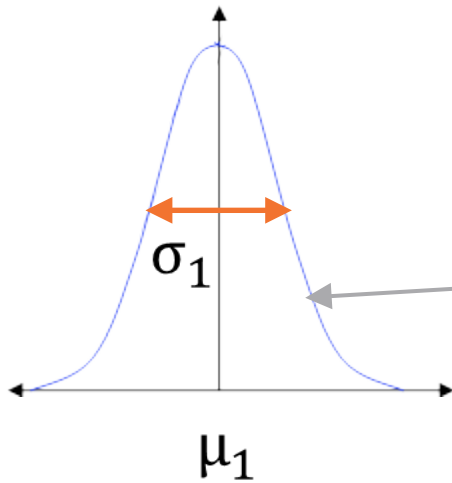


SPICE measurements

- Generate random samples from the distribution
- Simulate with each set of values

# Monte Carlo Analysis

$$Y = h(X_1, X_2, \dots, X_K)$$



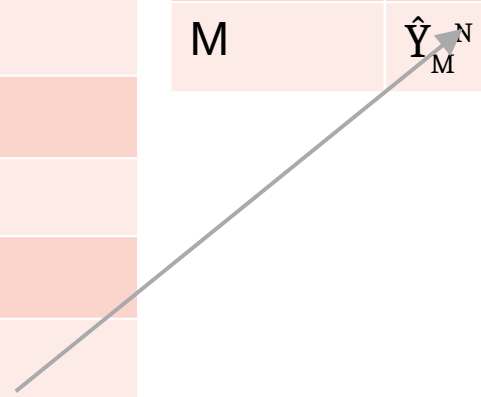
Trial #	$X_1, X_2, \dots, X_K$	Y
1	$x_1^1, x_2^1, \dots, x_K^1$	$Y^1$
2	$x_1^2, x_2^2, \dots, x_K^2$	$Y^2$
~		
N	$x_1^N, x_2^N, \dots, x_K^N$	$Y^N$
Mean		Sample Mean $\hat{Y}_1^N$
Variance		

# Monte Carlo Analysis

$$\hat{Y}_N = \frac{1}{N} \sum_{i=1}^N Y_i$$

Monte Carlo Run M		
Trial #		
1		
2		
~		
N		
Mean		$\hat{Y}_M^N$
Variance		

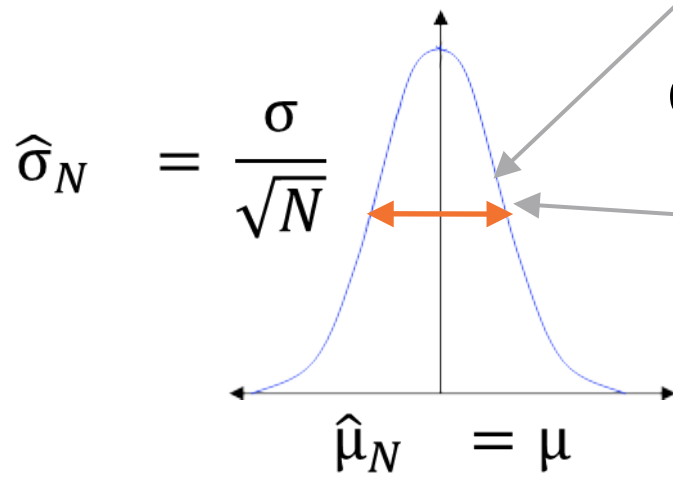
Run #	Mean
1	$\hat{Y}_1^N$
2	$\hat{Y}_1^N$
~	
M	$\hat{Y}_M^N$





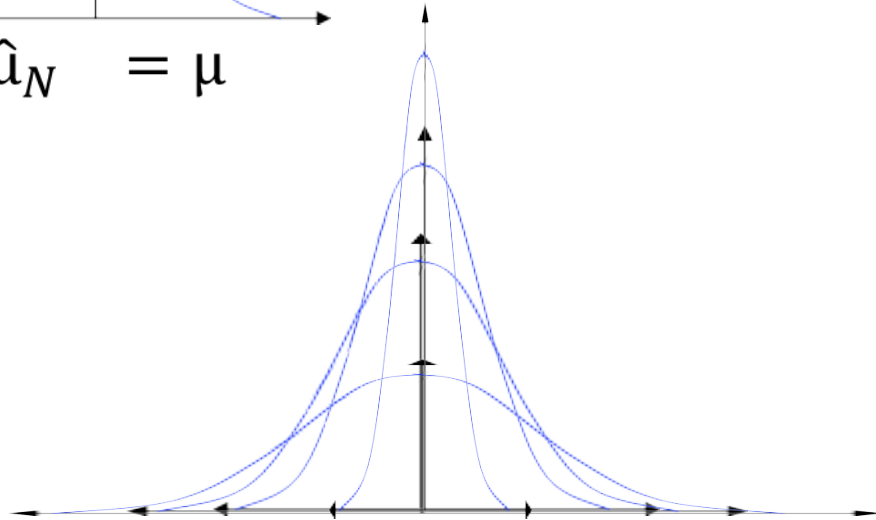
# Monte Carlo Analysis

$$\hat{Y}_N = \frac{1}{N} \sum_{i=1}^N Y_i$$



CLT - Gaussian

Run #	Mean
1	$\hat{Y}_1^1$
2	$\hat{Y}_1^2$
~	
M	$\hat{Y}_1^M$

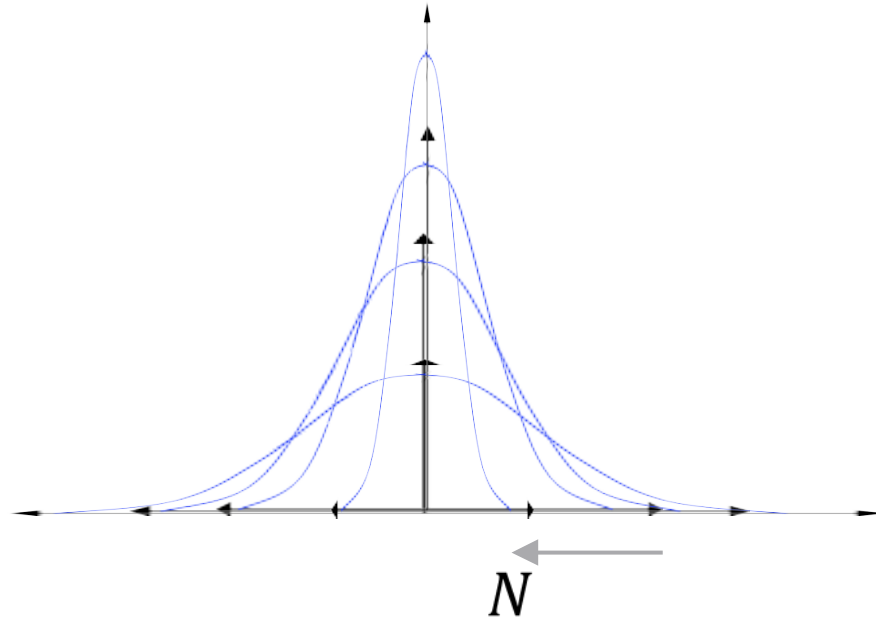


## Monte Carlo Analysis – Variance Reduction

$$\hat{Y}_N = \frac{1}{N} \sum_{i=1}^N Y_i$$

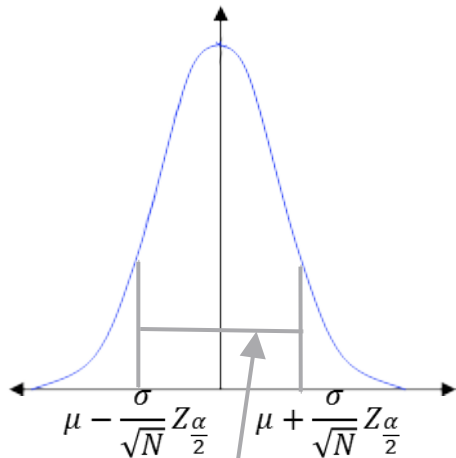
$$\hat{\sigma}_N = \frac{\sigma}{\sqrt{N}}$$

$$\hat{\mu}_N = \mu$$



- As  $N$  increases variance decreases
- By increasing  $N$ , you can get arbitrarily close

## Monte Carlo Analysis – Estimating N



Confidence interval =  $\epsilon$

$$2 \frac{\sigma}{\sqrt{N}} Z_{\frac{\alpha}{2}} = \epsilon$$

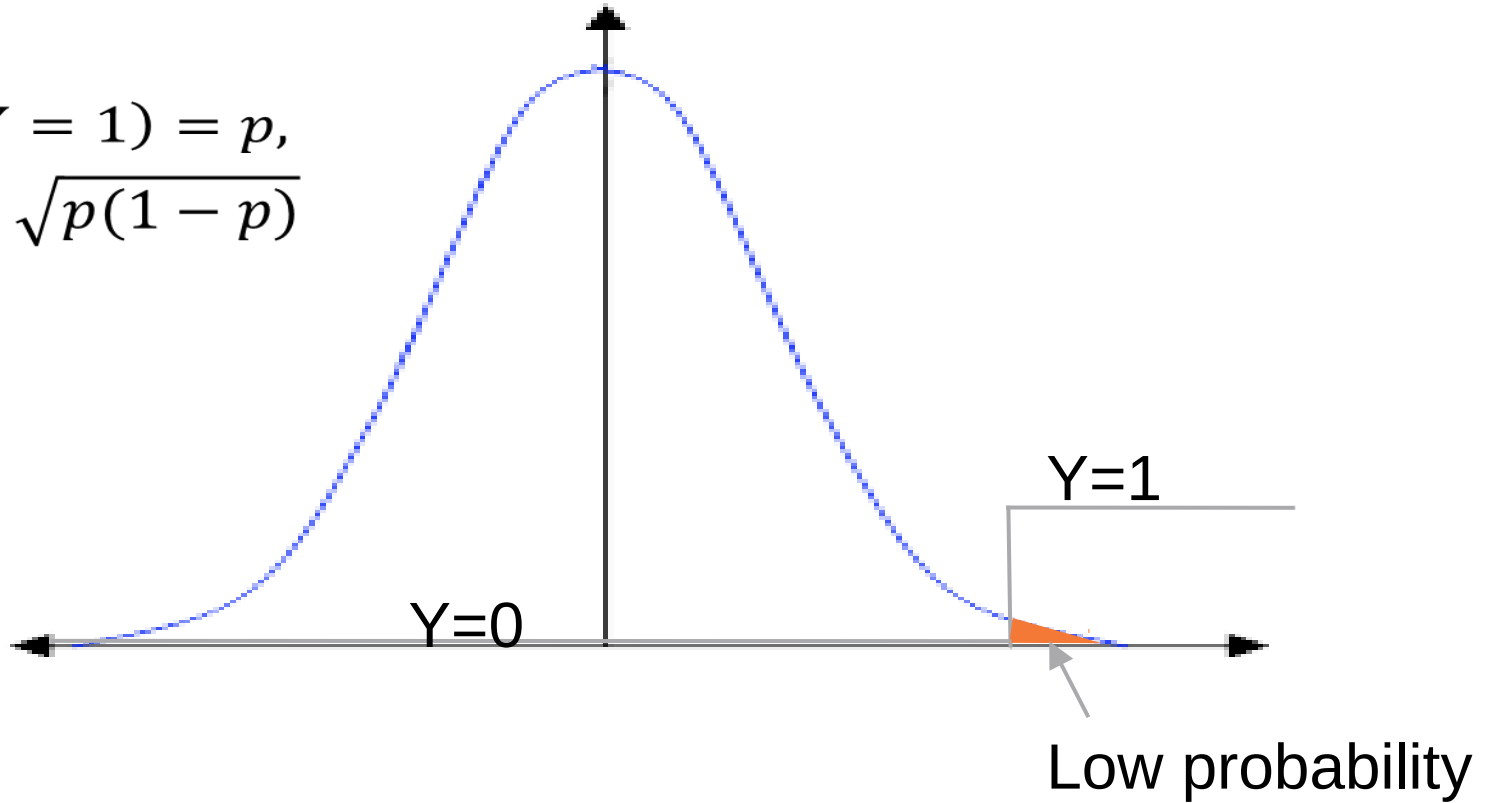
$$P\left(\frac{|\hat{Y}_N - \mu|}{\frac{\sigma}{\sqrt{N}}} > Z_{\frac{\alpha}{2}}\right) = 1 - \alpha$$

Standard Normal  
RV

$$N \geq \left[2 \left(\frac{\sigma}{\epsilon}\right) Z_{\frac{\alpha}{2}}\right]^2$$

## Rare Event Estimation

$$P(Y = 1) = p,$$
$$\sigma = \sqrt{p(1-p)}$$



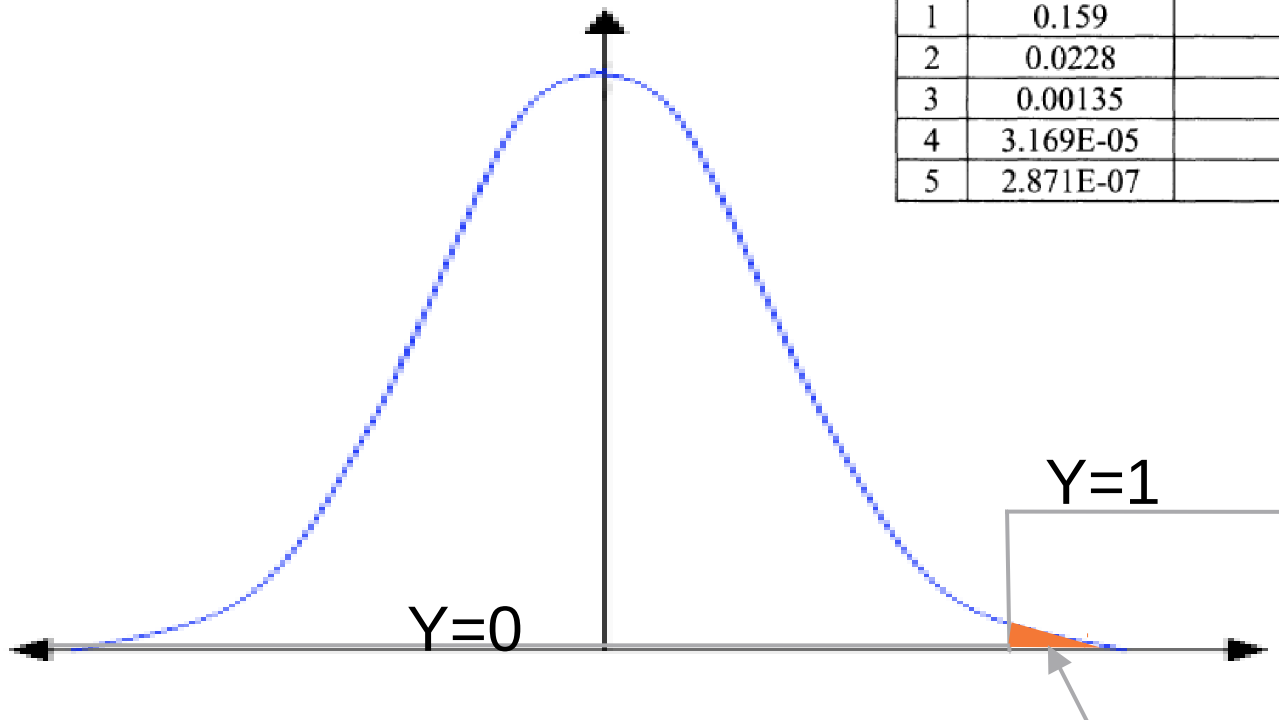
$$\varepsilon = 2\alpha p$$
$$Z_{\frac{\alpha}{2}} = 2 \quad - \text{95\% confidence}$$

$$N \geq \left[ \frac{4}{\alpha^2} \left( \frac{1-p}{p} \right) \right]$$

# Monte Carlo Analysis – Estimating N

**Table 1. Number of Monte Carlo simulations needed to estimate the probability  $P_f = \text{Prob}(x > z_0)$  with a 95% confidence interval =  $[P_f - 0.1P_f, P_f + 0.1P_f]$ . The corresponding simulation runtime in days, if a spice-like simulator is used.**

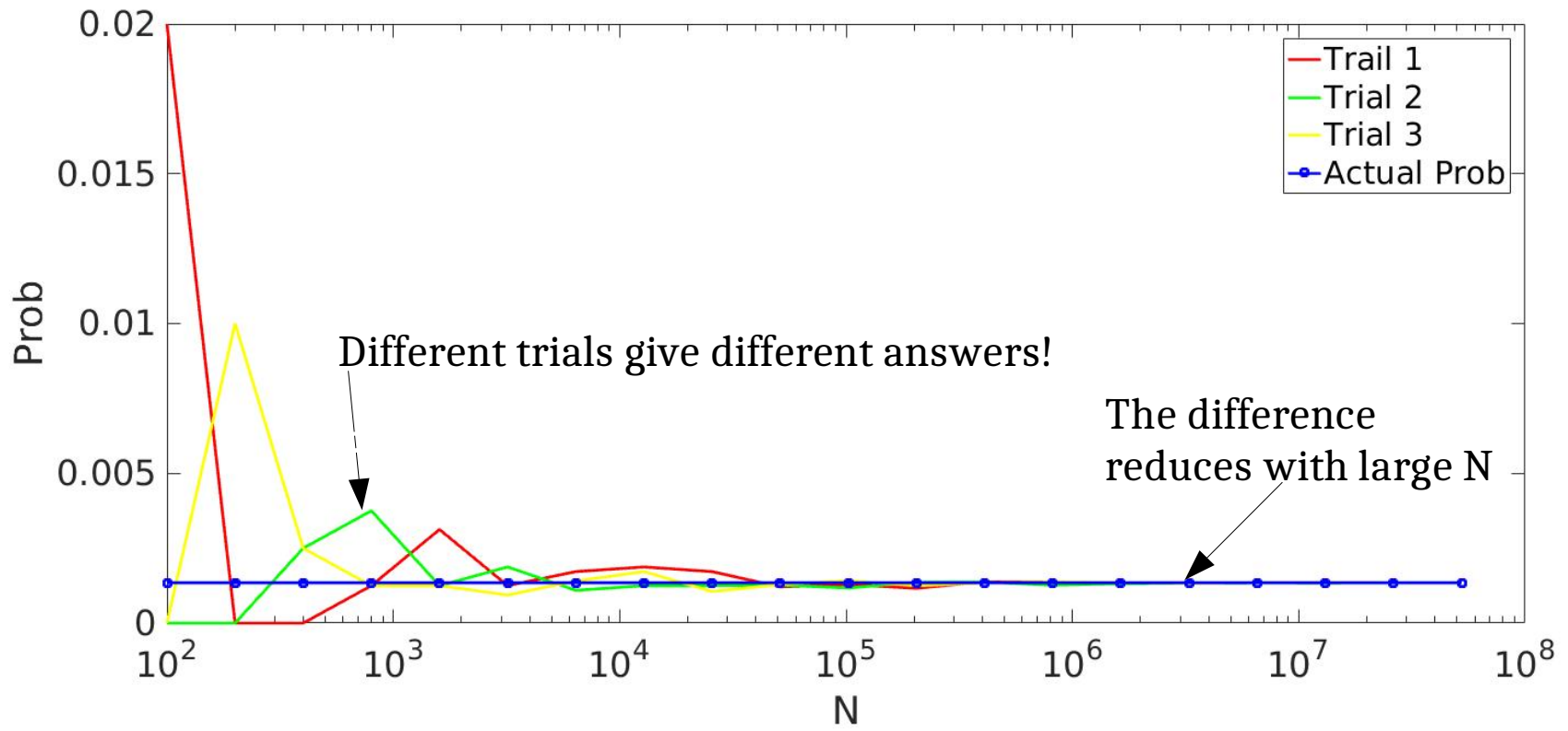
$z_0$	Probability value	Number of Monte Carlo Simulations	Runtime in Number of Days
0	0.500	4.0e2	0.18
1	0.159	2.1e3	0.972
2	0.0228	1.7e4	7.87
3	0.00135	2.9e5	Too long!
4	3.169E-05	1.3e7	Too long!
5	2.871E-07	1.4e9	Too long!



Rare event – “Unlikely” to be sampled by Monte-Carlo

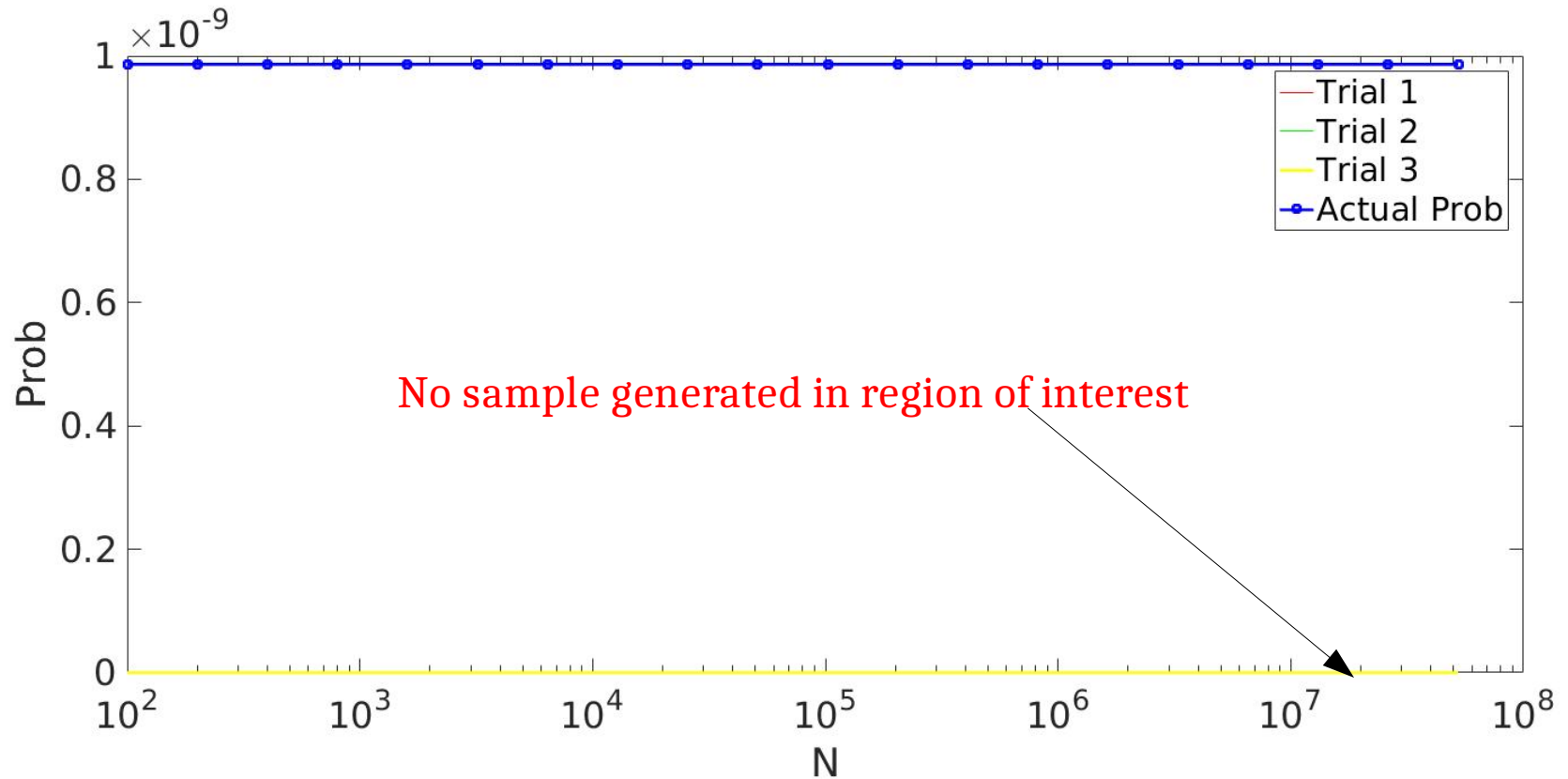
# Monte Carlo Estimation $P(Z > 1.5)$

Z – Standard Normal Random Variable



# Monte Carlo Estimation $P(Z > 6)$

Z – Standard Normal Random Variable

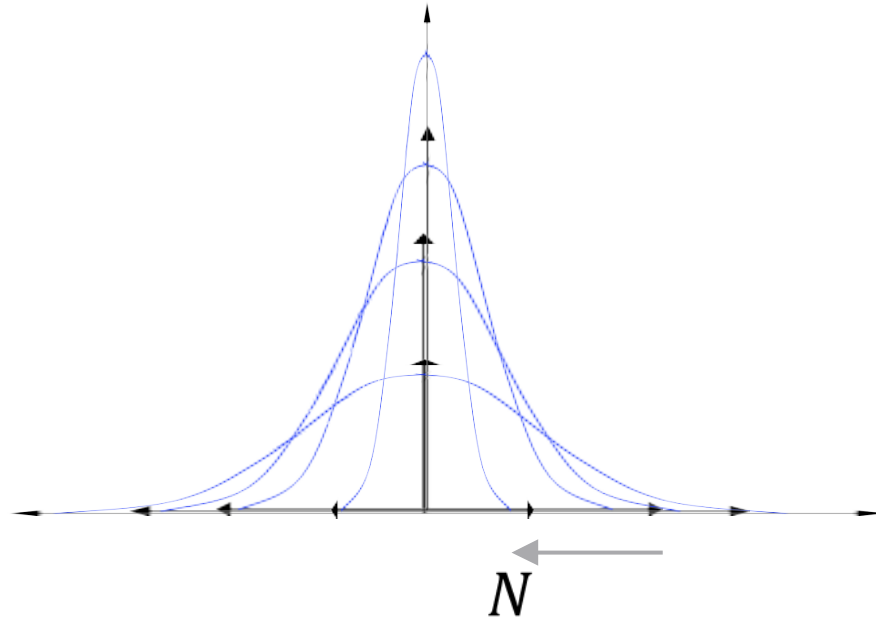


## Monte Carlo Analysis – Variance Reduction

$$\hat{Y}_N = \frac{1}{N} \sum_{i=1}^N Y_i$$

$$\hat{\sigma}_N = \frac{\sigma}{\sqrt{N}}$$

$$\hat{\mu}_N = \mu$$



- As N increases - variance decreases
- Can you reduce the variance in any other way?

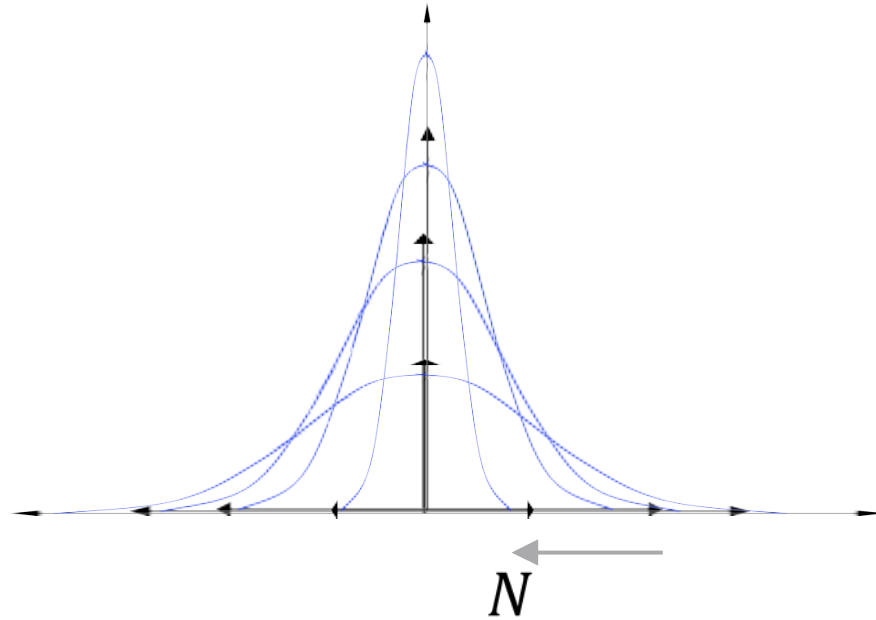


## Monte Carlo Analysis – Variance Reduction

$$\hat{Y}_N = \frac{1}{N} \sum_{i=1}^N Y_i$$

$$\hat{\sigma}_N = \frac{\sigma}{\sqrt{N}}$$

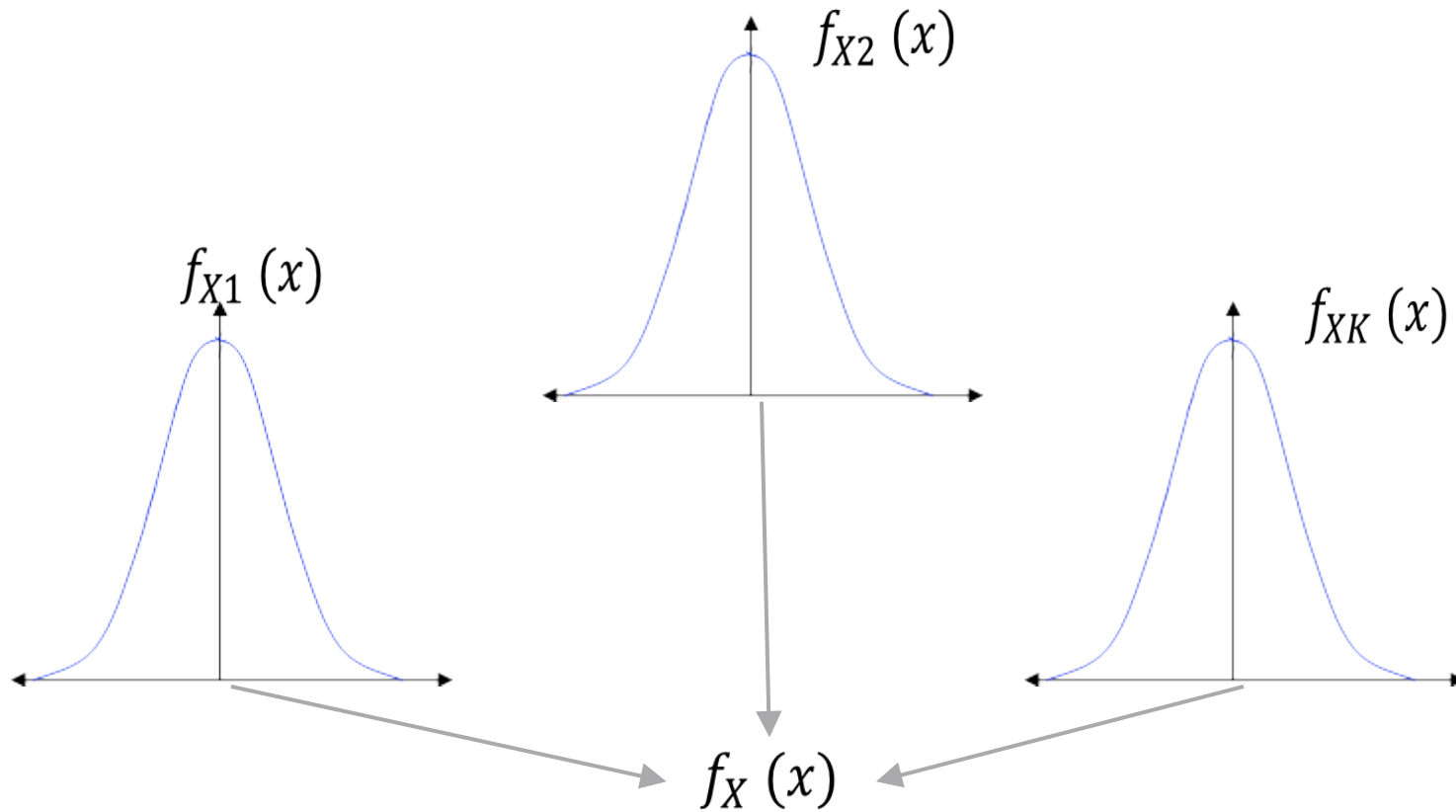
$$\hat{\mu}_N = \mu$$



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- Can you reduce the variance in any other way?

## Monte Carlo Analysis – Variance Reduction

$$Y = h(X_1, X_2, \dots, X_K)$$



## Monte Carlo Analysis – Variance Reduction

$$Y = h(X_1, X_2, \dots, X_K)$$

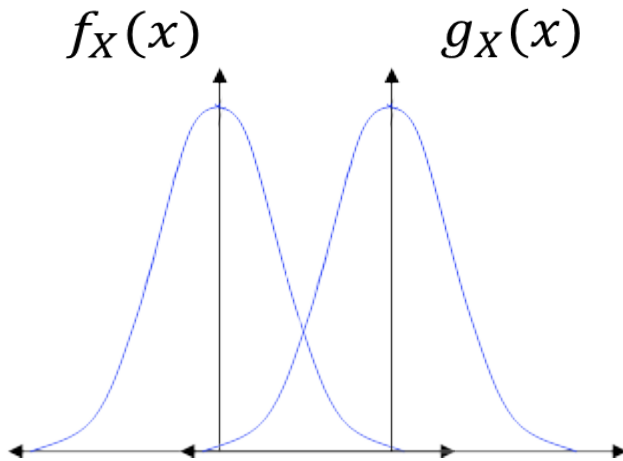
$$\mu = E_f[Y] = \int h(x) f_X(x) dx$$

$$\sigma^2 = \text{Var}_f[Y] = E_f[Y^2] - (E_f[Y])^2$$

$$\int (h(x))^2 f_X(x) dx$$

## Importance Sampling

$$Y = h(X_1, X_2, \dots, X_K)$$



$$Z = h(X) \frac{f_X(X)}{g_X(X)}$$

Define a new function  $Z$  where  $g_X(x)$  is a new distribution  
 $Z$  should have the same mean as  $Y$  by lower variance

## Importance Sampling - Mean

Y - X is drawn from f()

$$E_f[Y] = \int h(x) f_X(x) dx$$

Z - X is drawn from g()

$$E_g[Z] = \int h(x) \frac{f_X(x)}{g_X(x)} g_X(x) dx$$

## Importance Sampling - Variance

Y - X is drawn from f()

$$Y = h(X)$$

Z - X is drawn from g()

$$Z = h(X) \frac{f_X(X)}{g_X(X)}$$

$$\text{Var}_f[Y] = E_f[Y^2] - (E_f[Y])^2$$

$$\text{Var}_g[Z] = E_g[Z^2] - (E_g[Z])^2$$

$$E_f[Y] = \int h(x) f_X(x) dx$$

$$E_g[Z] = \int h(x) \frac{f_X(x)}{g_X(x)} g_X(x) dx$$

$$E_f[Y^2] = \int (h(x))^2 f_X(x) dx$$

$$E_g[Z^2] = \int (h(x))^2 \left( \frac{f_X(x)}{g_X(x)} \right)^2 g_X(x) dx$$

## Importance Sampling - Variance

$$E_g[Z^2] < E_f[Y^2]$$

← Desired!

$$E_f[Y^2] = \int (h(x))^2 f_X(x) dx$$

$$E_g[Z^2] = \int (h(x))^2 \left( \frac{f_X(x)}{g_X(x)} \right)^2 g_X(x) dx$$

$$E_g[Z^2] = \int (h(x))^2 \left( \frac{f_X(x)}{g_X(x)} \right) f_X(x) dx$$

## Importance Sampling - Variance

$$E_g[Z^2] < E_f[Y^2]$$

← Desired!

$$E_f[Y^2] = \int (h(x))^2 f_X(x) dx$$

$$E_g[Z^2] = \int (h(x))^2 \left( \frac{f_X(x)}{g_X(x)} \right) f_X(x) dx$$

Choose  $g(x)$  such that this ratio less than 1 for all values of  $x$ !



## Importance Sampling – Choice of $g(x)$

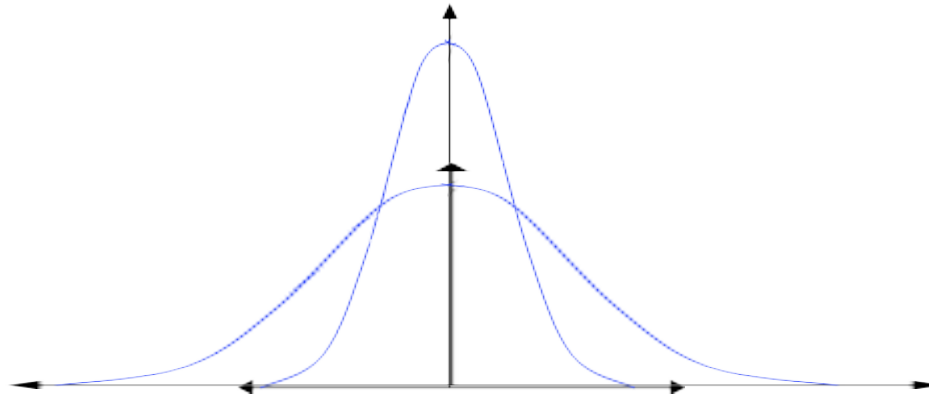
$$E_g \left( \frac{f_X(x)}{g_X(x)} \right) = \int \left( \frac{f_X(x)}{g_X(x)} \right) g_X(x) dx = 1$$

How can a function be less than 1 for all values of  $x$   
But have mean of 1?

## Importance Sampling – Variance – Choice of $g(x)$

$$E_g \left( \frac{f_X(x)}{g_X(x)} \right) = \int \left( \frac{f_X(x)}{g_X(x)} \right) g_X(x) dx = 1$$

How can a function be less than 1 for all values of  $x$   
But have mean of 1?



$g(x)$  is also a PDF – Has to integrate to unity!

## Importance Sampling – Choice of $g(x)$

$$E_g[Z^2] < E_f[Y^2]$$

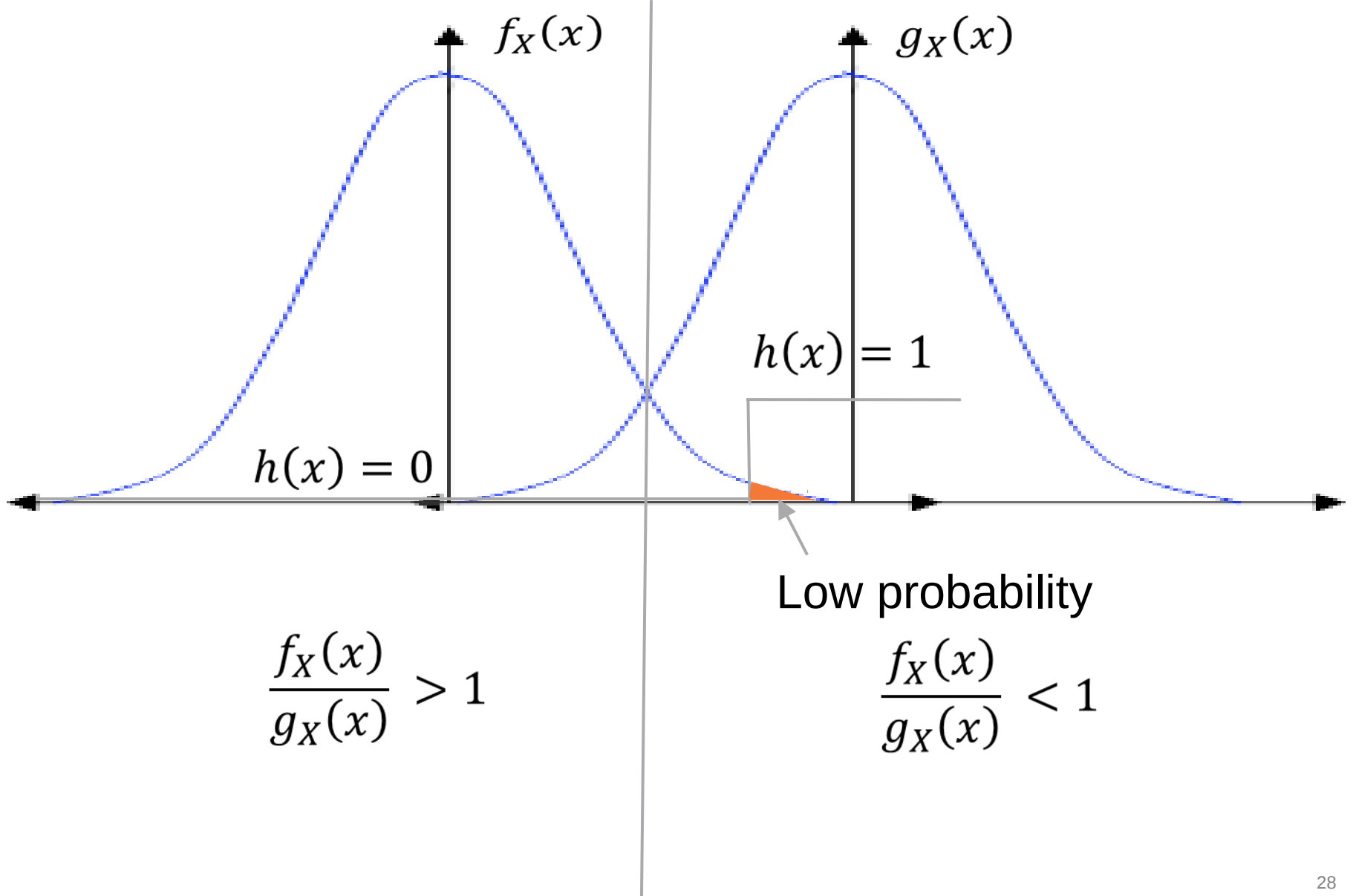
$$E_f[Y^2] = \int (h(x))^2 f_X(x) dx$$

$$E_g[Z^2] = \int (h(x))^2 \left( \frac{f_X(x)}{g_X(x)} \right) f_X(x) dx$$

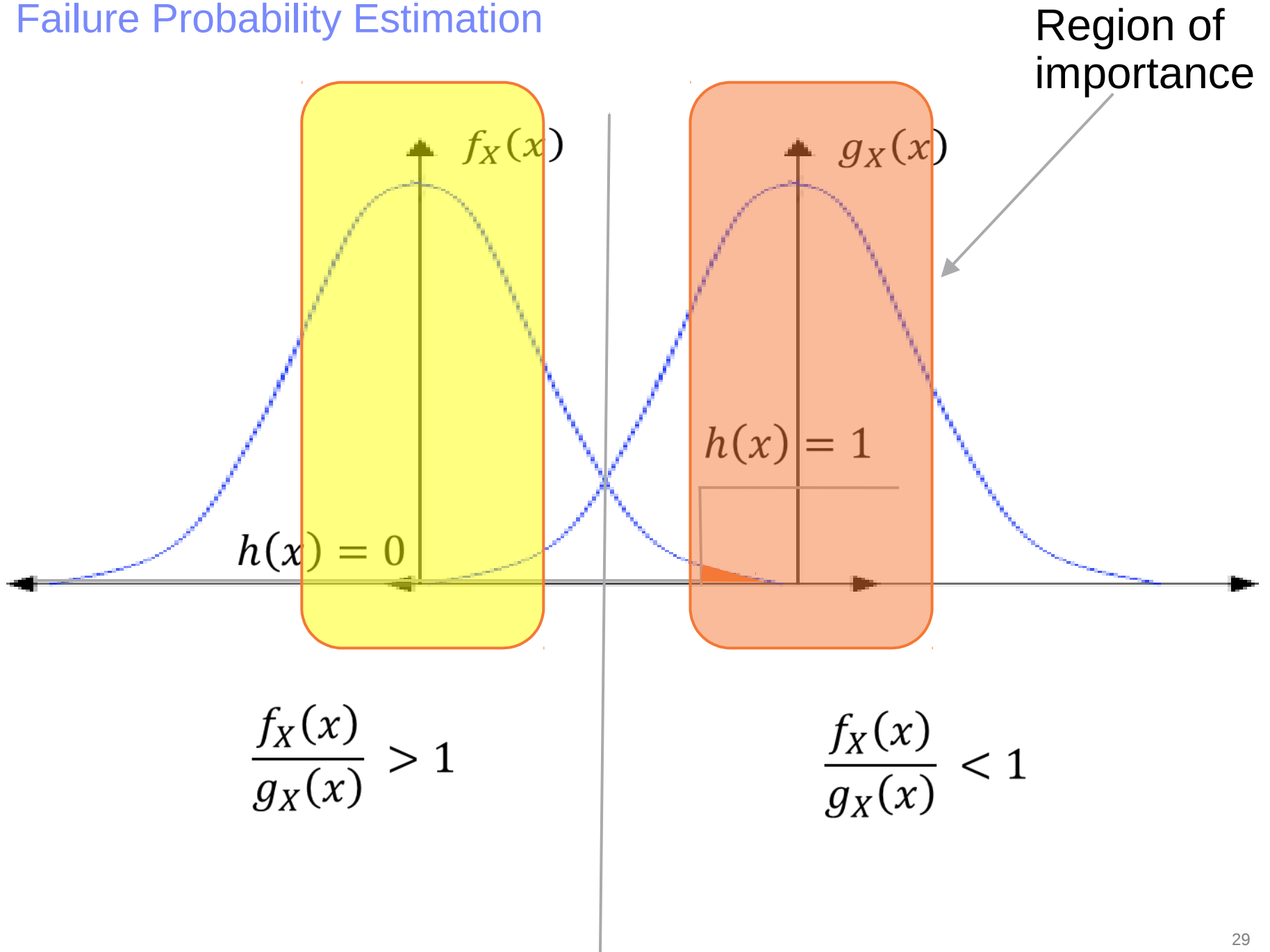


Ratio will be greater than 1 for some values of  $x$   
If  $h(x)$  is strictly zero in those regions?

Failure Probability Estimation –  $E[h(X)] = 1 \cdot p(X \geq a) + 0 \cdot p(X < a)$

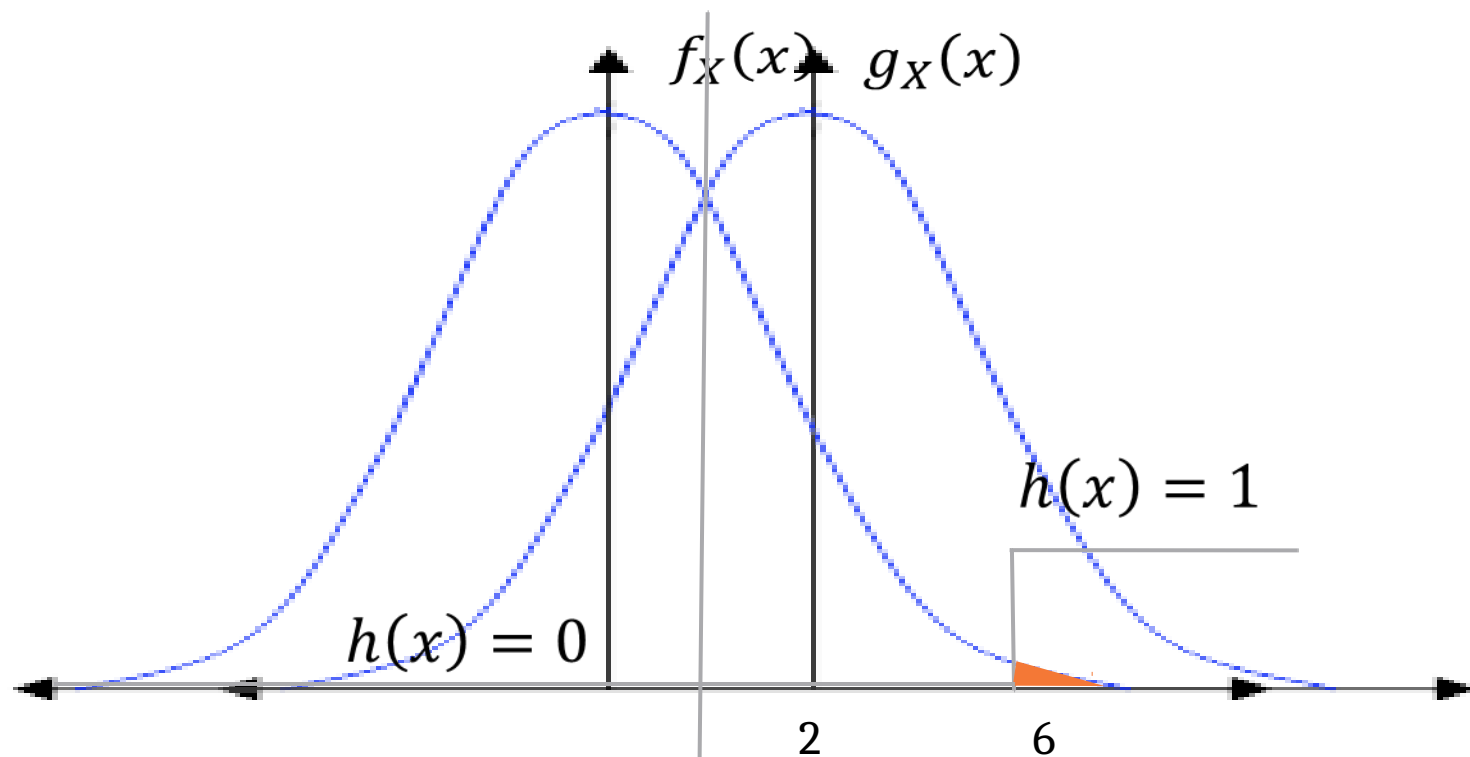


# Failure Probability Estimation



## Example: $P(Z > 6)$

Z – Standard Normal Random Variable

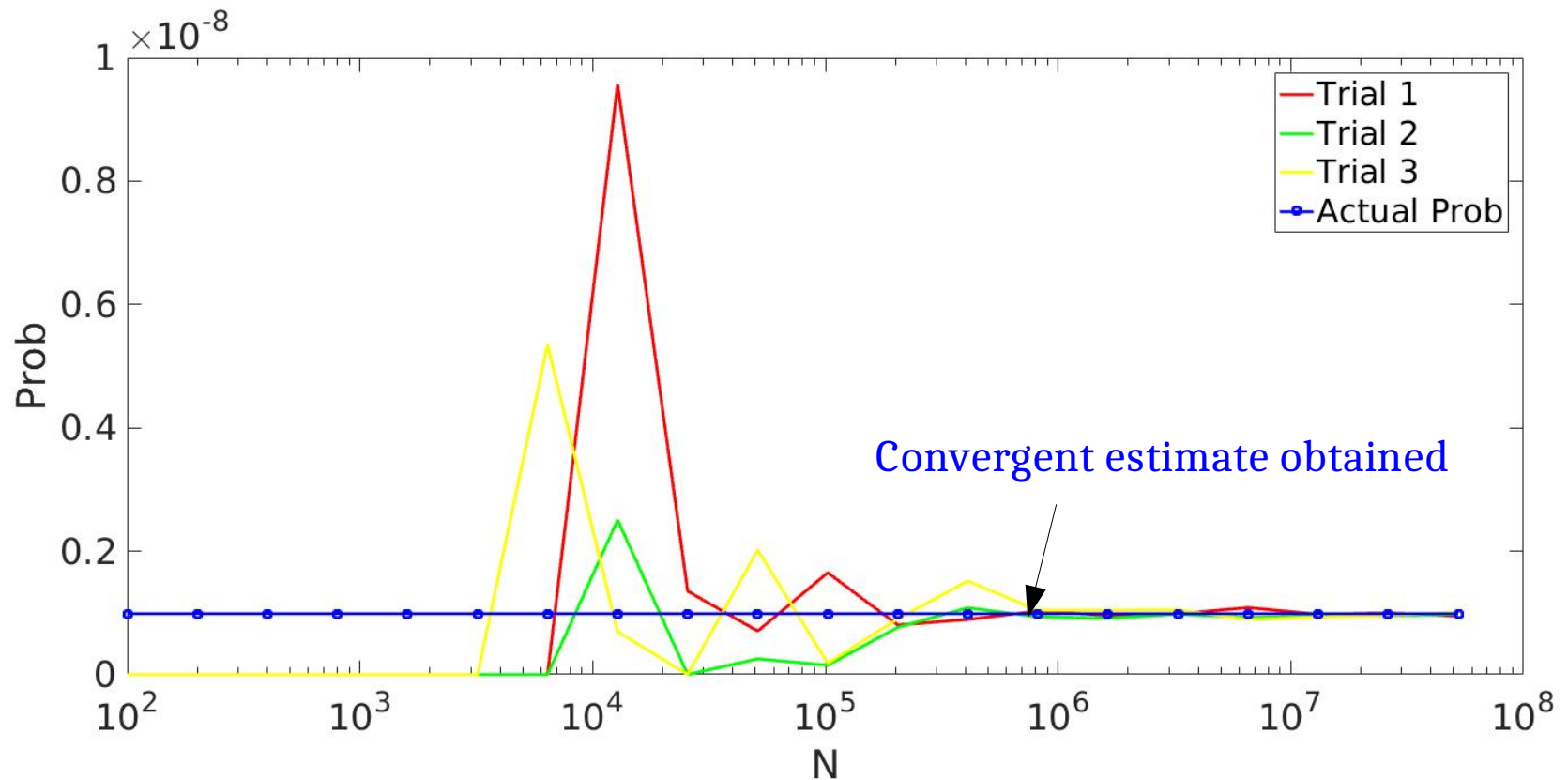


$$f_X(x) = \frac{1}{\sqrt{2\pi}} e^{-\frac{x^2}{2}}$$

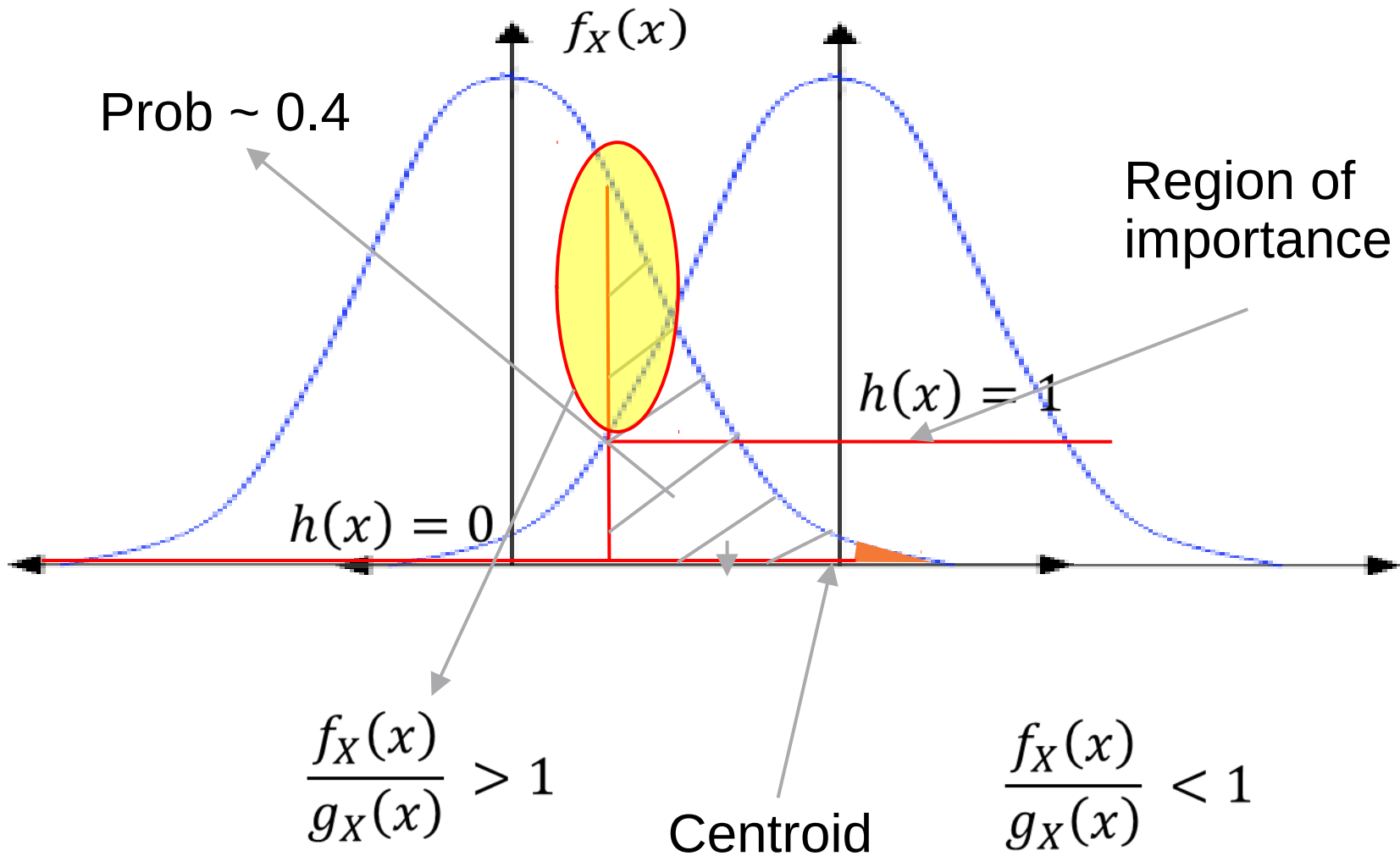
$$g_X(x) = \frac{1}{\sqrt{2\pi}} e^{-\frac{(x-2)^2}{2}}$$

# Estimation with Importance Sampling $P(Z > 6)$

Z – Standard Normal Random Variable



# Failure Probability Estimation - Where does it fail?



**Beware when estimating large probabilities!**



## References

- Kanj, R.; Joshi, R.; Nassif, S., "Mixture importance sampling and its application to the analysis of SRAM designs in the presence of rare failure events," in *Design Automation Conference, 2006 43rd ACM/IEEE* , vol., no., pp.69-72, 0-0 0 doi: 10.1109/DAC.2006.229167
- "Probability Models" second edition by Sheldon Ross
- "Introduction to Probability and Statistics" by Sheldon Ross